

Transistors (NPN)

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FEATURES

■ Power dissipation, P_{CM}:0.2W (T_{amb}=25°C)

■ Collector current, I_{CM}: 0.2A

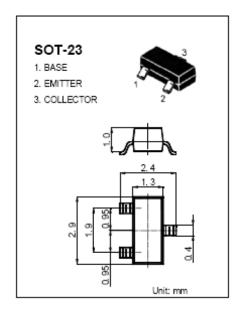
■ Collector-base voltage, V(BR)CBO: 60V

Operating and storage junction temperature range:

T_J, T_{stg}: -55 $^{\circ}$ C to +150 $^{\circ}$ C

■ SOT-23 plastic-encapsulate package

Device Marking: AM1



ELECTRICAL CHARACTERISTICS

Parameter	Symbol	Test Conditions	Min	Max	Unit
Collector-base breakdown voltage	V(BR)CBO	Ic= 100 μA, IE=0	60		V
Collector-emitter breakdown voltage	V(BR)CEO	VIc= 1 mA, IB=0		40	V
Emitter-base breakdown voltage	V(BR)EBO	IE= 100μA, IC=0	6		V
Collector cut-off current	Ісво	VCB= 60V, IE=0		0.1	μΑ
Collector cut-off current	ICEO	VCE= 40V, IB=0		0.1	μΑ
Emitter cut-off current	IEBO	VEB= 5V, IC=0		0.1	μΑ
DC current gain	HFE(1)	VCE=10V, IC= 1mA		100	
	HFE(2)	VCE= 1V, IC= 50mA	60	300	
Collector-emitter saturation voltage	VCE(sat)	IC=50mA, IB= 5mA		0.3	V
Base-emitter saturation voltage	VBE(sat)	IC= 50mA, IB= 5mA		0.95	V
Transition frequency	fτ	VCE= 20V, IC= 10mA f=100MHz	250		MHz
Delay Time	td	VCC=3.0Vdc,VBE=0.5Vdc		35	nS
Rise Time	tr	IC=10mAdc,IB1=1.0mAdc		35	nS
Storage Time	ts	VCC=3.0Vdc, IC=10mAdc		200	nS
Fall Time	tf	IB1=IB2=1.0mAdc		50	nS

Note: Unless otherwise specified, these specifications apply over the operating ambient temperature of 25°C.





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